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### **Understanding Embedded - FPGAs (Field Programmable Gate Array)**

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

### **Applications of Embedded - FPGAs**

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

#### **Details**

Product Status	Active
Number of LABs/CLBs	18840
Number of Logic Elements/Cells	241152
Total RAM Bits	15335424
Number of I/O	400
Number of Gates	-
Voltage - Supply	0.95V ~ 1.05V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	784-BBGA, FCBGA
Supplier Device Package	784-FCBGA (29x29)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/xilinx/xc6vlx240t-3ffg784c">https://www.e-xfl.com/product-detail/xilinx/xc6vlx240t-3ffg784c</a>

## Important Note

Typical values for quiescent supply current are specified at nominal voltage, 85°C junction temperatures ( $T_j$ ). Xilinx recommends analyzing static power consumption at  $T_j = 85^\circ\text{C}$  because the majority of designs operate near the high end of the commercial temperature range. Quiescent supply current is specified by speed grade for Virtex-6 devices. Use the XPower™ Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate static power consumption for conditions other than those specified in Table 4.

Table 4: Typical Quiescent Supply Current

Symbol	Description	Device	Speed and Temperature Grade						Units
			-3 (C)	-2 (C, E, & I)	-1 (C & I)	-1 (I & M) <sup>(2)</sup>	-1L (C)	-1L (I) <sup>(1)</sup>	
$I_{CCINTQ}$	Quiescent $V_{CCINT}$ supply current	XC6VLX75T	927	927	927	N/A	656	741	mA
		XC6VLX130T	1563	1563	1563	N/A	1102	1245	mA
		XC6VLX195T	2059	2059	2059	N/A	1441	1628	mA
		XC6VLX240T	2478	2478	2478	N/A	1733	1957	mA
		XC6VLX365T	3001	3001	3001	N/A	2092	2363	mA
		XC6VLX550T <sup>(3)</sup>	N/A	4515	4515	N/A	3147	3555	mA
		XC6VLX760 <sup>(3)</sup>	N/A	5094	5094	N/A	3471	3921	mA
		XC6V SX315T	3476	3476	3476	N/A	2409	2721	mA
		XC6V SX475T <sup>(3)</sup>	N/A	5227	5227	N/A	3622	4091	mA
		XC6VHX250T	2906	2906	2906	N/A	N/A	N/A	mA
		XC6VHX255T	2746	2746	2746	N/A	N/A	N/A	mA
		XC6VHX380T <sup>(4)</sup>	4160	4160	4160	N/A	N/A	N/A	mA
		XC6VHX565T <sup>(5)</sup>	N/A	5207	5207	N/A	N/A	N/A	mA
		XQ6VLX130T	N/A	1563	N/A	1563	N/A	1245	mA
		XQ6VLX240T	N/A	2478	N/A	2478	N/A	1957	mA
		XQ6VLX550T <sup>(7)</sup>	N/A	N/A	N/A	4515	N/A	3555	mA
		XQ6V SX315T	N/A	3476	N/A	3476	N/A	2721	mA
		XQ6V SX475T <sup>(7)</sup>	N/A	N/A	N/A	5227	N/A	4091	mA

Table 4: Typical Quiescent Supply Current (Cont'd)

Symbol	Description	Device	Speed and Temperature Grade					Units	
			-3 (C)	-2 (C, E, & I)	-1 (C & I)	-1 (I & M) <sup>(2)</sup>	-1L (C)		-1L (I) <sup>(1)</sup>
I <sub>CCOQ</sub>	Quiescent V <sub>CCO</sub> supply current	XC6VLX75T	1	1	1	N/A	1	1	mA
		XC6VLX130T	1	1	1	N/A	1	1	mA
		XC6VLX195T	1	1	1	N/A	1	1	mA
		XC6VLX240T	2	2	2	N/A	2	2	mA
		XC6VLX365T	2	2	2	N/A	2	2	mA
		XC6VLX550T <sup>(3)</sup>	N/A	3	3	N/A	3	3	mA
		XC6VLX760 <sup>(3)</sup>	N/A	3	3	N/A	3	3	mA
		XC6VSX315T	2	2	2	N/A	2	2	mA
		XC6VSX475T <sup>(3)</sup>	N/A	2	2	N/A	2	2	mA
		XC6VHX250T	1	1	1	N/A	N/A	N/A	mA
		XC6VHX255T	1	1	1	N/A	N/A	N/A	mA
		XC6VHX380T <sup>(4)</sup>	2	2	2	N/A	N/A	N/A	mA
		XC6VHX565T <sup>(5)</sup>	N/A	2	2	N/A	N/A	N/A	mA
		XQ6VLX130T	N/A	1	N/A	1	N/A	1	mA
		XQ6VLX240T	N/A	2	N/A	2	N/A	2	mA
		XQ6VLX550T <sup>(7)</sup>	N/A	N/A	N/A	3	N/A	3	mA
		XQ6VSX315T	N/A	2	N/A	2	N/A	2	mA
		XQ6VSX475T <sup>(7)</sup>	N/A	N/A	N/A	2	N/A	2	mA

## Power-On Power Supply Requirements

Xilinx FPGAs require a certain amount of supply current during power-on to insure proper device initialization. The actual current consumed depends on the power-on sequence and ramp rate of the power supply.

The recommended power-on sequence for Virtex-6 devices is  $V_{CCINT}$ ,  $V_{CCAUX}$ , and  $V_{CCO}$  to meet the power-up current requirements listed in Table 5.  $V_{CCINT}$  can be powered up or down at any time, but power up current specifications can vary from Table 5. The device will have no physical damage or reliability concerns if  $V_{CCINT}$ ,  $V_{CCAUX}$ , and  $V_{CCO}$  sequence cannot be followed.

If the recommended power-up sequence cannot be followed and the I/Os must remain 3-stated throughout configuration, then  $V_{CCAUX}$  must be powered prior to  $V_{CCO}$  or  $V_{CCAUX}$  and  $V_{CCO}$  must be powered by the same supply. Similarly, for power-down, the reverse  $V_{CCAUX}$  and  $V_{CCO}$  sequence is recommended if the I/Os are to remain 3-stated.

The GTH transceiver supplies must be powered using a MGTHAVCC, MGTHAVCCR, MGTHAVCCPLL, and MGTHAVTT sequence. There are no sequencing requirement for these supplies with respect to the other FPGA supply voltages. For more detail see Table 27: *GTH Transceiver Power Supply Sequencing*. There are no sequencing requirements for the GTX transceivers power supplies.

Table 5 shows the minimum current, in addition to  $I_{CCO}$ , that are required by Virtex-6 devices for proper power-on and configuration. If the current minimums shown in Table 4 and Table 5 are met, the device powers on after all three supplies have passed through their power-on reset threshold voltages. The FPGA must be configured after applying  $V_{CCINT}$ ,  $V_{CCAUX}$ , and  $V_{CCO}$  for the appropriate configuration banks. Once initialized and configured, use the XPE tools to estimate current drain on these supplies.

**Table 5: Power-On Current for Virtex-6 Devices**

Device	$I_{CCINTMIN}$	$I_{CCAUXMIN}$	$I_{CCOMIN}$	Units
	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	Typ <sup>(1)</sup>	
XC6VLX75T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 10$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VLX130T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 10$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VLX195T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VLX240T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VLX365T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VLX550T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VLX760	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VSX315T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VSX475T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 50$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VHX250T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VHX255T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VHX380T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XC6VHX565T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 40$	$I_{CCOQ} + 30$ mA per bank	mA
XQ6VLX130T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 100$	$I_{CCOQ} + 30$ mA per bank	mA
XQ6VLX240T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 100$	$I_{CCOQ} + 30$ mA per bank	mA
XQ6VLX550T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 100$	$I_{CCOQ} + 30$ mA per bank	mA
XQ6VSX315T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 100$	$I_{CCOQ} + 40$ mA per bank	mA
XQ6VSX475T	See $I_{CCINTQ}$ in Table 4	$I_{CCAUXQ} + 100$	$I_{CCOQ} + 40$ mA per bank	mA

**Notes:**

1. Typical values are specified at nominal voltage, 25°C.
2. Use the XPower Estimator (XPE) spreadsheet tool (download at <http://www.xilinx.com/power>) to calculate maximum power-on currents.

## GTX Transceiver Specifications

### GTX Transceiver DC Characteristics

Table 13: Absolute Maximum Ratings for GTX Transceivers<sup>(1)</sup>

Symbol	Description	Min	Max	Units
MGTAVCC	Analog supply voltage for the GTX transmitter and receiver circuits relative to GND	-0.5	1.1	V
MGTAVTT	Analog supply voltage for the GTX transmitter and receiver termination circuits relative to GND	-0.5	1.32	V
MGTAVTTRCAL	Analog supply voltage for the resistor calibration circuit of the GTX transceiver column	-0.5	1.32	V
V <sub>IN</sub>	Receiver (RXP/RXN) and Transmitter (TXP/TXN) absolute input voltage	-0.5	1.32	V
V <sub>MGTREFCLK</sub>	Reference clock absolute input voltage	-0.5	1.32	V

**Notes:**

- Stresses beyond those listed under Absolute Maximum Ratings might cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those listed under Operating Conditions is not implied. Exposure to Absolute Maximum Ratings conditions for extended periods of time might affect device reliability.

Table 14: Recommended Operating Conditions for GTX Transceivers<sup>(1)(2)</sup>

Symbol	Description	Speed Grade	PLL Frequency	Min	Typ	Max	Units
MGTAVCC	Analog supply voltage for the GTX transmitter and receiver circuits relative to GND	-3, -2 <sup>(3)</sup>	> 2.7 GHz	1.0	1.03	1.06	V
		-3, -2 <sup>(3)</sup>	≤ 2.7 GHz	0.95	1.0	1.06	V
		-1	≤ 2.7 GHz	0.95	1.0	1.06	V
		-1L	≤ 2.7 GHz	0.95	1.0	1.05	V
MGTAVTT	Analog supply voltage for the GTX transmitter and receiver termination circuits relative to GND	All	–	1.14	1.2	1.26	V
MGTAVTTRCAL	Analog supply voltage for the resistor calibration circuit of the GTX transceiver column	All	–	1.14	1.2	1.26	V

**Notes:**

- Each voltage listed requires the filter circuit described in [UG366: Virtex-6 FPGA GTX Transceivers User Guide](#).
- Voltages are specified for the temperature range of T<sub>j</sub> = -40°C to +100°C for all XC devices and T<sub>j</sub> = -55°C to +125°C for the XQ devices
- If a GTX Quad contains transceivers operating with a mixture of PLL frequencies above and below 2.7 GHz, the MGTAVCC voltage supply must be in the range of 1.0V to 1.06V.

Table 15: GTX Transceiver Supply Current (per Lane) <sup>(1)(2)</sup>

Symbol	Description	Typ	Max	Units
I <sub>MGTAVTT</sub>	MGTAVTT supply current for one GTX transceiver	55.9	Note 2	mA
I <sub>MGTAVCC</sub>	MGTAVCC supply current for one GTX transceiver	56.1		mA
MGTR <sub>REF</sub>	Precision reference resistor for internal calibration termination	100.0 ± 1% tolerance		Ω

**Notes:**

- Typical values are specified at nominal voltage, 25°C, with a 3.125 Gb/s line rate.
- Values for currents of other transceiver configurations and conditions can be obtained by using the XPower Estimator (XPE) or XPower Analyzer (XPA) tools.

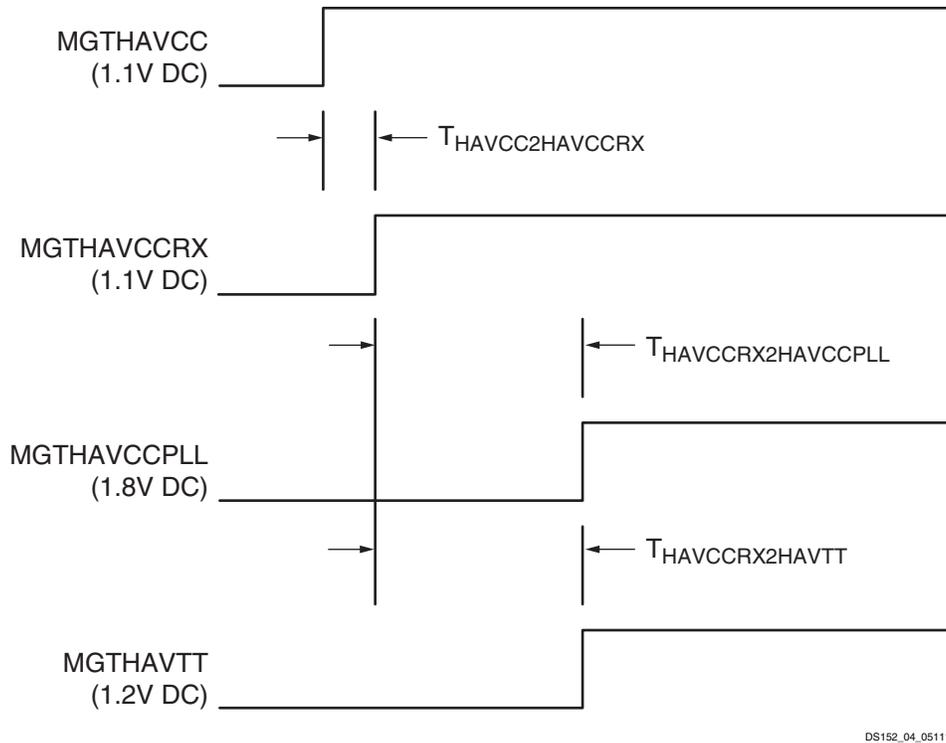
Table 23: GTX Transceiver Transmitter Switching Characteristics

Symbol	Description	Condition	Min	Typ	Max	Units
F <sub>GTXTX</sub>	Serial data rate range		0.480	–	F <sub>GTXMAX</sub>	Gb/s
T <sub>RTX</sub>	TX Rise time	20%–80%	–	120	–	ps
T <sub>FTX</sub>	TX Fall time	80%–20%	–	120	–	ps
T <sub>LLSKEW</sub>	TX lane-to-lane skew <sup>(1)</sup>		–	–	350	ps
V <sub>TXOOBVDPP</sub>	Electrical idle amplitude		–	–	15	mV
T <sub>TXOOBTRANSITION</sub>	Electrical idle transition time		–	–	75	ns
TJ <sub>6.5</sub>	Total Jitter <sup>(2)(3)</sup>	6.5 Gb/s	–	–	0.33	UI
DJ <sub>6.5</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.17	UI
TJ <sub>5.0</sub>	Total Jitter <sup>(2)(3)</sup>	5.0 Gb/s	–	–	0.33	UI
DJ <sub>5.0</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.15	UI
TJ <sub>4.25</sub>	Total Jitter <sup>(2)(3)</sup>	4.25 Gb/s	–	–	0.33	UI
DJ <sub>4.25</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.14	UI
TJ <sub>3.75</sub>	Total Jitter <sup>(2)(3)</sup>	3.75 Gb/s	–	–	0.34	UI
DJ <sub>3.75</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.16	UI
TJ <sub>3.125</sub>	Total Jitter <sup>(2)(3)</sup>	3.125 Gb/s	–	–	0.2	UI
DJ <sub>3.125</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.1	UI
TJ <sub>3.125L</sub>	Total Jitter <sup>(2)(3)</sup>	3.125 Gb/s <sup>(4)</sup>	–	–	0.35	UI
DJ <sub>3.125L</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.16	UI
TJ <sub>2.5</sub>	Total Jitter <sup>(2)(3)</sup>	2.5 Gb/s <sup>(5)</sup>	–	–	0.20	UI
DJ <sub>2.5</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.08	UI
TJ <sub>1.25</sub>	Total Jitter <sup>(2)(3)</sup>	1.25 Gb/s <sup>(6)</sup>	–	–	0.15	UI
DJ <sub>1.25</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.06	UI
TJ <sub>600</sub>	Total Jitter <sup>(2)(3)</sup>	600 Mb/s	–	–	0.1	UI
DJ <sub>600</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.03	UI
TJ <sub>480</sub>	Total Jitter <sup>(2)(3)</sup>	480 Mb/s	–	–	0.1	UI
DJ <sub>480</sub>	Deterministic Jitter <sup>(2)(3)</sup>		–	–	0.03	UI

**Notes:**

- Using same REFCLK input with TXENPMPHASEALIGN enabled for up to 12 consecutive transmitters (three fully populated GTX Quads).
- Using PLL\_DIVSEL\_FB = 2, 20-bit internal data width. These values are NOT intended for protocol specific compliance determinations.
- All jitter values are based on a bit-error ratio of 1e<sup>-12</sup>.
- PLL frequency at 1.5625 GHz and OUTDIV = 1.
- PLL frequency at 2.5 GHz and OUTDIV = 2.
- PLL frequency at 2.5 GHz and OUTDIV = 4.

Figure 4 shows the timing parameters in Table 27.



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Figure 4: GTH Transceiver Power Supply Power-On Sequencing

Table 28: GTH Transceiver Supply Current

Symbol	Description	Typ <sup>(1)</sup>	Max	Units
I <sub>MGTHAVCC</sub>	MGTHAVCC supply current for one GTH Quad (4 lanes)	571	Note 2	mA
I <sub>MGTHAVCCR X</sub>	MGTHAVCCR X supply current for a GTH Quad (4 lanes)	254	Note 2	mA
I <sub>MGTHAVTT</sub>	MGTHAVTT supply current for one GTH Quad (4 lanes)	93	Note 2	mA
I <sub>MGTHAVCCPLL</sub>	MGTHAVCCPLL supply current for one GTH Quad (4 lanes)	219	Note 2	mA
MGTR <sub>REF</sub>	Precision reference resistor for internal calibration termination	1000.0 ± 1% tolerance		Ω

**Notes:**

1. Typical values are specified at nominal voltage, 25°C, with a 10.3125 Gb/s line rate.
2. Values for currents other than the values specified in this table can be obtained by using the XPower Estimator (XPE) or XPower Analyzer (XPA) tools.

Table 29: GTH Transceiver Quiescent Supply Current<sup>(1)(2)</sup>

Symbol	Description	Typ <sup>(3)</sup>	Max	Units
I <sub>MGTHAVCCQ</sub>	Quiescent MGTHAVCC Supply Current for one GTH Quad (4 lanes)	65	Note 4	mA
I <sub>MGTHAVCCR XQ</sub>	Quiescent MGTHAVCCR X Supply Current for one GTH Quad (4 lanes)	17	Note 4	mA
I <sub>MGTHAVTTQ</sub>	Quiescent MGTHAVTT Supply Current for one GTH Quad (4 lanes)	1	Note 4	mA
I <sub>MGTHAVCCPLLQ</sub>	Quiescent MGTHAVCCPLL Supply Current for one GTH Quad (4 lanes)	1	Note 4	mA

**Notes:**

1. Device powered and unconfigured.
2. GTH transceiver quiescent supply current for an entire device can be calculated by multiplying the values in this table by the number of available GTH transceivers.
3. Typical values are specified at nominal voltage, 25°C.
4. Currents for conditions other than values specified in this table can be obtained by using the XPE or XPA tools.

**Table 40: Analog-to-Digital Specifications (Cont'd)**

Parameter	Symbol	Comments/Conditions	Min	Typ	Max	Units
<b>Analog Inputs<sup>(3)</sup></b>						
Dedicated Analog Inputs Input Voltage Range $V_P - V_N$		Unipolar Operation	0	–	1	Volts
		Bipolar Operation	–0.5	–	+0.5	
		Unipolar Common Mode Range (FS input)	0	–	+0.5	
		Bipolar Common Mode Range (FS input)	+0.5	–	+0.6	
		Bandwidth	–	20	–	MHz
Auxiliary Analog Inputs Input Voltage Range $V_{AUXP[0]} / V_{AUXN[0]}$ to $V_{AUXP[15]} / V_{AUXN[15]}$ $T_j = -55^{\circ}\text{C}$ to $125^{\circ}\text{C}$		Unipolar Operation	0	–	1	Volts
		Bipolar Operation	–0.5	–	+0.5	
		Unipolar Common Mode Range (FS input)	0	–	+0.5	
		Bipolar Common Mode Range (FS input)	+0.5	–	+0.6	
		Bandwidth	–	10	–	kHz
Input Leakage Current		A/D not converting, ADCCLK stopped	–	$\pm 1.0$	–	$\mu\text{A}$
Input Capacitance			–	10	–	pF
On-chip Supply Monitor Error		$V_{CCINT}$ and $V_{CCAUX}$ with calibration enabled. External 1.25V reference $T_j = -55^{\circ}\text{C}$ to $125^{\circ}\text{C}$ .	–	–	$\pm 1.0$	% Reading
		$V_{CCINT}$ and $V_{CCAUX}$ with calibration enabled. Internal reference $T_j = -40^{\circ}\text{C}$ to $100^{\circ}\text{C}$ . <sup>(4)</sup>	–	$\pm 2$	–	% Reading
On-chip Temperature Monitor Error		$T_j = -55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$ with calibration enabled. External 1.25V reference.	–	–	$\pm 4$	$^{\circ}\text{C}$
		$T_j = -40^{\circ}\text{C}$ to $+100^{\circ}\text{C}$ with calibration enabled. Internal reference. <sup>(4)</sup>	–	$\pm 5$	–	$^{\circ}\text{C}$
<b>External Reference Inputs<sup>(5)</sup></b>						
Positive Reference Input Voltage Range	$V_{REFP}$	Measured Relative to $V_{REFN}$	1.20	1.25	1.30	Volts
Negative Reference Input Voltage Range	$V_{REFN}$	Measured Relative to AGND	–50	0	100	mV
Input current	$I_{REF}$	ADCCLK = 5.2 MHz	–	–	100	$\mu\text{A}$
<b>Power Requirements</b>						
Analog Power Supply	$AV_{DD}$	Measured Relative to $AV_{SS}$	2.375	2.5	2.625	Volts
Analog Supply Current	$AI_{DD}$	ADCCLK = 5.2 MHz	–	–	12	mA

**Notes:**

- Offset errors are removed by enabling the System Monitor automatic gain calibration feature.
- See "System Monitor Timing" in [UG370: Virtex-6 FPGA System Monitor User Guide](#)
- See "Analog Inputs" in [UG370: Virtex-6 FPGA System Monitor User Guide](#) for a detailed description.
- These internal references are not specified over the junction temperature operating range for military (M) temperature devices.
- Any variation in the reference voltage from the nominal  $V_{REFP} = 1.25\text{V}$  and  $V_{REFN} = 0\text{V}$  will result in a deviation from the ideal transfer function. This also impacts the accuracy of the internal sensor measurements (i.e., temperature and power supply). However, for external ratiometric type applications allowing reference to vary by  $\pm 4\%$  is permitted.

### IOB Pad Input/Output/3-State Switching Characteristics

Table 44 (for commercial (XC) Virtex-6 devices) and Table 45 (for the Defense-grade (XQ) Virtex-6 devices) summarizes the values of standard-specific data input delay adjustments, output delays terminating at pads (based on standard) and 3-state delays.

$T_{IOPI}$  is described as the delay from IOB pad through the input buffer to the I-pin of an IOB pad. The delay varies depending on the capability of the SelectIO input buffer.

$T_{IOOP}$  is described as the delay from the O pin to the IOB pad through the output buffer of an IOB pad. The delay varies depending on the capability of the SelectIO output buffer.

$T_{IOTP}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is disabled. The delay varies depending on the SelectIO capability of the output buffer.

Table 46 summarizes the value of  $T_{IOTPHZ}$ .  $T_{IOTPHZ}$  is described as the delay from the T pin to the IOB pad through the output buffer of an IOB pad, when 3-state is enabled (i.e., a high impedance state).

Table 44: IOB Switching Characteristics for the Commercial (XC) Virtex-6 Devices

I/O Standard	$T_{IOPI}$				$T_{IOOP}$				$T_{IOTP}$				Units
	Speed Grade				Speed Grade				Speed Grade				
	-3	-2	-1	-1L	-3	-2	-1	-1L	-3	-2	-1	-1L	
LVDS_25	0.85	0.94	1.09	1.08	1.45	1.54	1.68	1.62	1.45	1.54	1.68	1.62	ns
LVDSEXT_25	0.85	0.94	1.09	1.08	1.53	1.65	1.84	1.73	1.53	1.65	1.84	1.73	ns
HT_25	0.85	0.94	1.09	1.08	1.51	1.62	1.78	1.69	1.51	1.62	1.78	1.69	ns
BLVDS_25	0.85	0.94	1.09	1.08	1.39	1.50	1.67	1.65	1.39	1.50	1.67	1.65	ns
RSDS_25 (point to point)	0.85	0.94	1.09	1.08	1.45	1.54	1.68	1.62	1.45	1.54	1.68	1.62	ns
HSTL_I	0.81	0.91	1.06	1.06	1.45	1.56	1.73	1.71	1.45	1.56	1.73	1.71	ns
HSTL_II	0.81	0.91	1.06	1.06	1.44	1.56	1.74	1.72	1.44	1.56	1.74	1.72	ns
HSTL_III	0.81	0.91	1.06	1.06	1.42	1.54	1.71	1.69	1.42	1.54	1.71	1.69	ns
HSTL_I_18	0.81	0.91	1.06	1.06	1.47	1.58	1.75	1.72	1.47	1.58	1.75	1.72	ns
HSTL_II_18	0.81	0.91	1.06	1.06	1.50	1.62	1.81	1.78	1.50	1.62	1.81	1.78	ns
HSTL_III_18	0.81	0.91	1.06	1.06	1.42	1.54	1.71	1.69	1.42	1.54	1.71	1.69	ns
SSTL2_I	0.81	0.91	1.06	1.06	1.49	1.60	1.77	1.74	1.49	1.60	1.77	1.74	ns
SSTL2_II	0.81	0.91	1.06	1.06	1.42	1.54	1.72	1.71	1.42	1.54	1.72	1.71	ns
SSTL15	0.81	0.91	1.06	1.06	1.42	1.54	1.71	1.69	1.42	1.54	1.71	1.69	ns
LVC MOS25, Slow, 2 mA	0.51	0.57	0.66	0.70	5.09	5.46	6.01	5.63	5.09	5.46	6.01	5.63	ns
LVC MOS25, Slow, 4 mA	0.51	0.57	0.66	0.70	3.30	3.49	3.79	3.65	3.30	3.49	3.79	3.65	ns
LVC MOS25, Slow, 6 mA	0.51	0.57	0.66	0.70	2.62	2.81	3.08	2.95	2.62	2.81	3.08	2.95	ns
LVC MOS25, Slow, 8 mA	0.51	0.57	0.66	0.70	2.21	2.41	2.72	2.59	2.21	2.41	2.72	2.59	ns
LVC MOS25, Slow, 12 mA	0.51	0.57	0.66	0.70	1.80	1.95	2.17	2.10	1.80	1.95	2.17	2.10	ns
LVC MOS25, Slow, 16 mA	0.51	0.57	0.66	0.70	1.89	2.05	2.29	2.21	1.89	2.05	2.29	2.21	ns
LVC MOS25, Slow, 24 mA	0.51	0.57	0.66	0.70	1.68	1.82	2.02	1.98	1.68	1.82	2.02	1.98	ns
LVC MOS25, Fast, 2 mA	0.51	0.57	0.66	0.70	5.12	5.49	6.04	5.62	5.12	5.49	6.04	5.62	ns
LVC MOS25, Fast, 4 mA	0.51	0.57	0.66	0.70	3.28	3.50	3.82	3.65	3.28	3.50	3.82	3.65	ns
LVC MOS25, Fast, 6 mA	0.51	0.57	0.66	0.70	2.56	2.73	2.99	2.88	2.56	2.73	2.99	2.88	ns
LVC MOS25, Fast, 8 mA	0.51	0.57	0.66	0.70	2.11	2.33	2.65	2.53	2.11	2.33	2.65	2.53	ns
LVC MOS25, Fast, 12 mA	0.51	0.57	0.66	0.70	1.74	1.88	2.08	2.03	1.74	1.88	2.08	2.03	ns
LVC MOS25, Fast, 16 mA	0.51	0.57	0.66	0.70	1.77	1.92	2.13	2.08	1.77	1.92	2.13	2.08	ns

Table 44: IOB Switching Characteristics for the Commercial (XC) Virtex-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	-3	-2	-1	-1L	-3	-2	-1	-1L	-3	-2	-1	-1L	
LVC MOS25, Fast, 24 mA	0.51	0.57	0.66	0.70	1.66	1.79	1.99	1.96	1.66	1.79	1.99	1.96	ns
LVC MOS18, Slow, 2 mA	0.55	0.61	0.71	0.73	4.21	4.47	4.87	4.30	4.21	4.47	4.87	4.30	ns
LVC MOS18, Slow, 4 mA	0.55	0.61	0.71	0.73	2.79	2.96	3.21	2.94	2.79	2.96	3.21	2.94	ns
LVC MOS18, Slow, 6 mA	0.55	0.61	0.71	0.73	2.30	2.43	2.64	2.47	2.30	2.43	2.64	2.47	ns
LVC MOS18, Slow, 8 mA	0.55	0.61	0.71	0.73	2.01	2.11	2.27	2.24	2.01	2.11	2.27	2.24	ns
LVC MOS18, Slow, 12 mA	0.55	0.61	0.71	0.73	1.88	1.99	2.15	2.10	1.88	1.99	2.15	2.10	ns
LVC MOS18, Slow, 16 mA	0.55	0.61	0.71	0.73	1.84	1.95	2.11	2.04	1.84	1.95	2.11	2.04	ns
LVC MOS18, Fast, 2 mA	0.55	0.61	0.71	0.73	4.00	4.23	4.57	4.08	4.00	4.23	4.57	4.08	ns
LVC MOS18, Fast, 4 mA	0.55	0.61	0.71	0.73	2.62	2.76	2.97	2.74	2.62	2.76	2.97	2.74	ns
LVC MOS18, Fast, 6 mA	0.55	0.61	0.71	0.73	2.15	2.28	2.46	2.32	2.15	2.28	2.46	2.32	ns
LVC MOS18, Fast, 8 mA	0.55	0.61	0.71	0.73	1.90	1.99	2.13	2.14	1.90	1.99	2.13	2.14	ns
LVC MOS18, Fast, 12 mA	0.55	0.61	0.71	0.73	1.69	1.80	1.97	1.88	1.69	1.80	1.97	1.88	ns
LVC MOS18, Fast, 16 mA	0.55	0.61	0.71	0.73	1.63	1.74	1.91	1.88	1.63	1.74	1.91	1.88	ns
LVC MOS15, Slow, 2 mA	0.64	0.73	0.85	0.85	3.43	3.77	4.29	3.91	3.43	3.77	4.29	3.91	ns
LVC MOS15, Slow, 4 mA	0.64	0.73	0.85	0.85	2.58	2.79	3.10	2.93	2.58	2.79	3.10	2.93	ns
LVC MOS15, Slow, 6 mA	0.64	0.73	0.85	0.85	2.08	2.32	2.68	2.50	2.08	2.32	2.68	2.50	ns
LVC MOS15, Slow, 8 mA	0.64	0.73	0.85	0.85	1.81	1.98	2.23	2.24	1.81	1.98	2.23	2.24	ns
LVC MOS15, Slow, 12 mA	0.64	0.73	0.85	0.85	1.76	1.91	2.13	2.07	1.76	1.91	2.13	2.07	ns
LVC MOS15, Slow, 16 mA	0.64	0.73	0.85	0.85	1.69	1.83	2.04	1.98	1.69	1.83	2.04	1.98	ns
LVC MOS15, Fast, 2 mA	0.64	0.73	0.85	0.85	3.44	3.77	4.28	3.91	3.44	3.77	4.28	3.91	ns
LVC MOS15, Fast, 4 mA	0.64	0.73	0.85	0.85	2.37	2.53	2.78	2.66	2.37	2.53	2.78	2.66	ns
LVC MOS15, Fast, 6 mA	0.64	0.73	0.85	0.85	1.80	2.05	2.42	2.16	1.80	2.05	2.42	2.16	ns
LVC MOS15, Fast, 8 mA	0.64	0.73	0.85	0.85	1.76	1.90	2.11	2.04	1.76	1.90	2.11	2.04	ns
LVC MOS15, Fast, 12 mA	0.64	0.73	0.85	0.85	1.64	1.77	1.97	1.90	1.64	1.77	1.97	1.90	ns
LVC MOS15, Fast, 16 mA	0.64	0.73	0.85	0.85	1.62	1.76	1.96	1.92	1.62	1.76	1.96	1.92	ns
LVC MOS12, Slow, 2 mA	0.72	0.81	0.93	0.95	3.14	3.39	3.75	3.54	3.14	3.39	3.75	3.54	ns
LVC MOS12, Slow, 4 mA	0.72	0.81	0.93	0.95	2.43	2.63	2.93	2.79	2.43	2.63	2.93	2.79	ns
LVC MOS12, Slow, 6 mA	0.72	0.81	0.93	0.95	1.92	2.11	2.41	2.26	1.92	2.11	2.41	2.26	ns
LVC MOS12, Slow, 8 mA	0.72	0.81	0.93	0.95	1.87	2.02	2.25	2.17	1.87	2.02	2.25	2.17	ns
LVC MOS12, Fast, 2 mA	0.72	0.81	0.93	0.95	2.71	2.98	3.39	3.11	2.71	2.98	3.39	3.11	ns
LVC MOS12, Fast, 4 mA	0.72	0.81	0.93	0.95	1.93	2.16	2.51	2.31	1.93	2.16	2.51	2.31	ns
LVC MOS12, Fast, 6 mA	0.72	0.81	0.93	0.95	1.75	1.89	2.11	2.05	1.75	1.89	2.11	2.05	ns
LVC MOS12, Fast, 8 mA	0.72	0.81	0.93	0.95	1.69	1.82	2.02	1.98	1.69	1.82	2.02	1.98	ns
LVDCI_25	0.51	0.57	0.66	0.70	2.05	2.14	2.26	2.26	2.05	2.14	2.26	2.26	ns
LVDCI_18	0.55	0.61	0.71	0.73	2.07	2.23	2.47	2.38	2.07	2.23	2.47	2.38	ns
LVDCI_15	0.64	0.73	0.85	0.85	1.85	2.01	2.24	2.18	1.85	2.01	2.24	2.18	ns

Table 44: IOB Switching Characteristics for the Commercial (XC) Virtex-6 Devices (Cont'd)

I/O Standard	T <sub>IOPI</sub>				T <sub>IOOP</sub>				T <sub>IOTP</sub>				Units
	Speed Grade				Speed Grade				Speed Grade				
	-3	-2	-1	-1L	-3	-2	-1	-1L	-3	-2	-1	-1L	
DIFF_SSTL18_I	0.85	0.94	1.09	1.08	1.47	1.58	1.75	1.73	1.47	1.58	1.75	1.73	ns
DIFF_SSTL18_I_DCI	0.85	0.94	1.09	1.08	1.40	1.51	1.67	1.65	1.40	1.51	1.67	1.65	ns
DIFF_SSTL18_II	0.85	0.94	1.09	1.08	1.39	1.50	1.67	1.66	1.39	1.50	1.67	1.66	ns
DIFF_SSTL18_II_DCI	0.85	0.94	1.09	1.08	1.36	1.47	1.63	1.62	1.36	1.47	1.63	1.62	ns
DIFF_SSTL18_II_T_DCI	0.85	0.94	1.09	1.08	1.40	1.51	1.67	1.65	1.40	1.51	1.67	1.65	ns
DIFF_SSTL15	0.81	0.91	1.06	1.06	1.42	1.54	1.71	1.69	1.42	1.54	1.71	1.69	ns
DIFF_SSTL15_DCI	0.81	0.91	1.06	1.06	1.41	1.52	1.68	1.66	1.41	1.52	1.68	1.66	ns
DIFF_SSTL15_T_DCI	0.81	0.91	1.06	1.06	1.41	1.52	1.68	1.66	1.41	1.52	1.68	1.66	ns

Table 45: IOB Switching Characteristics for the Defense-grade (XQ) Virtex-6 Devices

I/O Standard	T <sub>IOPI</sub>			T <sub>IOOP</sub>			T <sub>IOTP</sub>			Units
	Speed Grade			Speed Grade			Speed Grade			
	-2	-1	-1L	-2	-1	-1L	-2	-1	-1L	
LVDS_25	0.94	1.09	1.08	1.54	2.16	1.62	1.54	2.16	1.62	ns
LVDSEXT_25	0.94	1.09	1.08	1.65	2.20	1.73	1.65	2.20	1.73	ns
HT_25	0.94	1.09	1.08	1.62	2.20	1.69	1.62	2.20	1.69	ns
BLVDS_25	0.94	1.09	1.08	1.50	3.18	1.65	1.50	3.18	1.65	ns
RSDS_25 (point to point)	0.94	1.09	1.08	1.54	2.22	1.62	1.54	2.22	1.62	ns
HSTL_I	0.91	1.06	1.06	1.56	2.44	1.71	1.56	2.44	1.71	ns
HSTL_II	0.91	1.06	1.06	1.56	2.21	1.72	1.56	2.21	1.72	ns
HSTL_III	0.91	1.06	1.06	1.54	2.50	1.69	1.54	2.50	1.69	ns
HSTL_I_18	0.91	1.06	1.06	1.58	2.43	1.72	1.58	2.43	1.72	ns
HSTL_II_18	0.91	1.06	1.06	1.62	2.30	1.78	1.62	2.30	1.78	ns
HSTL_III_18	0.91	1.06	1.06	1.54	2.49	1.69	1.54	2.49	1.69	ns
SSTL2_I	0.91	1.06	1.06	1.60	2.50	1.74	1.60	2.50	1.74	ns
SSTL2_II	0.91	1.06	1.06	1.54	2.49	1.71	1.54	2.49	1.71	ns
SSTL15	0.91	1.06	1.06	1.54	2.07	1.69	1.54	2.07	1.69	ns
LVC MOS25, Slow, 2 mA	0.57	0.66	0.70	5.46	6.01	5.63	5.46	6.01	5.63	ns
LVC MOS25, Slow, 4 mA	0.57	0.66	0.70	3.49	3.79	3.65	3.49	3.79	3.65	ns
LVC MOS25, Slow, 6 mA	0.57	0.66	0.70	2.81	3.08	2.95	2.81	3.08	2.95	ns
LVC MOS25, Slow, 8 mA	0.57	0.66	0.70	2.41	2.72	2.59	2.41	2.72	2.59	ns
LVC MOS25, Slow, 12 mA	0.57	0.66	0.70	1.95	2.23	2.10	1.95	2.23	2.10	ns
LVC MOS25, Slow, 16 mA	0.57	0.66	0.70	2.05	2.29	2.21	2.05	2.29	2.21	ns
LVC MOS25, Slow, 24 mA	0.57	0.66	0.70	1.82	2.24	1.98	1.82	2.24	1.98	ns
LVC MOS25, Fast, 2 mA	0.57	0.66	0.70	5.49	6.04	5.62	5.49	6.04	5.62	ns
LVC MOS25, Fast, 4 mA	0.57	0.66	0.70	3.50	3.82	3.65	3.50	3.82	3.65	ns
LVC MOS25, Fast, 6 mA	0.57	0.66	0.70	2.73	2.99	2.88	2.73	2.99	2.88	ns
LVC MOS25, Fast, 8 mA	0.57	0.66	0.70	2.33	2.65	2.53	2.33	2.65	2.53	ns
LVC MOS25, Fast, 12 mA	0.57	0.66	0.70	1.88	2.08	2.03	1.88	2.08	2.03	ns

Table 50: OLOGIC Switching Characteristics

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
<b>Setup/Hold</b>							
$T_{ODCK}/T_{OCKD}$	D1/D2 pins Setup/Hold with respect to CLK	0.45/ -0.08	0.50/ -0.08	0.54/ -0.08	0.54/ -0.08	0.69/ -0.11	ns
$T_{OOCECK}/T_{OCKOCE}$	OCE pin Setup/Hold with respect to CLK	0.17/ -0.03	0.20/ -0.03	0.22/ -0.03	0.27/ -0.05	0.27/ -0.04	ns
$T_{OSRCK}/T_{OCKSR}$	SR pin Setup/Hold with respect to CLK	0.59/ -0.24	0.62/ -0.24	0.54/ -0.08	0.54/ -0.08	0.79/ -0.35	ns
$T_{OTCK}/T_{OCKT}$	T1/T2 pins Setup/Hold with respect to CLK	0.44/ -0.07	0.51/ -0.07	0.56/ -0.07	0.60/ -0.10	0.68/ -0.13	ns
$T_{OTCECK}/T_{OCKTCE}$	TCE pin Setup/Hold with respect to CLK	0.15/ -0.04	0.19/ -0.04	0.21/ -0.04	0.27/ -0.05	0.29/ -0.05	ns
<b>Combinatorial</b>							
$T_{DOQ}$	D1 to OQ out or T1 to TQ out	0.78	0.87	1.01	1.01	1.15	ns
<b>Sequential Delays</b>							
$T_{OCKQ}$	CLK to OQ/TQ out	0.54	0.61	0.71	0.71	0.80	ns
$T_{RQ}$	SR pin to OQ/TQ out	0.80	0.90	1.05	1.05	1.19	ns
$T_{GSRQ}$	Global Set/Reset to Q outputs	7.60	7.60	10.51	10.51	10.51	ns
<b>Set/Reset</b>							
$T_{RPW}$	Minimum Pulse Width, SR inputs	0.78	0.95	1.20	1.20	1.30	ns, Min

## Input/Output Delay Switching Characteristics

Table 53: Input/Output Delay Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
<b>IDELAYCTRL</b>						
T <sub>DLYCCO_RDY</sub>	Reset to Ready for IDELAYCTRL	3.00	3.00	3.00	3.25	μs
F <sub>IDELAYCTRL_REF</sub>	REFCLK frequency = 200.0 <sup>(1)</sup>	200	200	200	200	MHz
	REFCLK frequency = 300.0 <sup>(1)</sup>	300	300	–	–	MHz
IDELAYCTRL_REF_PRECISION	REFCLK precision	±10	±10	±10	±10	MHz
T <sub>IDELAYCTRL_RPW</sub>	Minimum Reset pulse width	50.00	50.00	50.00	52.50	ns
<b>IODELAY</b>						
T <sub>IDELAYRESOLUTION</sub>	IODELAY Chain Delay Resolution	1/(32 x 2 x F <sub>REF</sub> )				ps
T <sub>IDELAYPAT_JIT</sub>	Pattern dependent period jitter in delay chain for clock pattern. <sup>(2)</sup>	0	0	0	0	ps per tap
	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23). <sup>(3)</sup>	±5	±5	±5	±5	ps per tap
	Pattern dependent period jitter in delay chain for random data pattern (PRBS 23). <sup>(4)</sup>	±9	±9	±9	±9	ps per tap
T <sub>IODELAY_CLK_MAX</sub>	Maximum frequency of CLK input to IODELAY	500.00	420.00	300.00	300.00	MHz
T <sub>IODCKC_CE</sub> / T <sub>IODCKC_CE</sub>	CE pin Setup/Hold with respect to CK	0.45/ –0.09	0.53/ –0.09	0.65/ –0.09	0.84/ –0.14	ns
T <sub>IODCK_INC</sub> / T <sub>IODCKC_INC</sub>	INC pin Setup/Hold with respect to CK	0.23/ –0.02	0.27/ –0.01	0.31/ 0.00	0.27/ –0.04	ns
T <sub>IODCKC_RST</sub> / T <sub>IODCKC_RST</sub>	RST pin Setup/Hold with respect to CK	0.57/ –0.08	0.62/ –0.08	0.69/ –0.08	0.74/ –0.13	ns
T <sub>IODDO_T</sub>	TSCONTROL delay to MUXE/MUXF switching and through IODELAY	Note 5	Note 5	Note 5	Note 5	ps
T <sub>IODDO_IDATAIN</sub>	Propagation delay through IODELAY	Note 5	Note 5	Note 5	Note 5	ps
T <sub>IODDO_ODATAIN</sub>	Propagation delay through IODELAY	Note 5	Note 5	Note 5	Note 5	ps

**Notes:**

1. Average Tap Delay at 200 MHz = 78 ps, at 300 MHz = 52 ps.
2. When HIGH\_PERFORMANCE mode is set to TRUE or FALSE.
3. When HIGH\_PERFORMANCE mode is set to TRUE
4. When HIGH\_PERFORMANCE mode is set to FALSE.
5. Delay depends on IODELAY tap setting. See TRACE report for actual values.

## CLB Switching Characteristics

Table 54: CLB Switching Characteristics

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
<b>Combinatorial Delays</b>						
T <sub>ILO</sub>	An – Dn LUT address to A	0.06	0.07	0.07	0.09	ns, Max
	An – Dn LUT address to AMUX/CMUX	0.18	0.20	0.22	0.25	ns, Max
	An – Dn LUT address to BMUX_A	0.28	0.31	0.36	0.40	ns, Max

Table 54: CLB Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
T <sub>ITO</sub>	An – Dn inputs to A – D Q outputs	0.59	0.67	0.79	0.85	ns, Max
T <sub>AXA</sub>	AX inputs to AMUX output	0.31	0.35	0.42	0.44	ns, Max
T <sub>AXB</sub>	AX inputs to BMUX output	0.35	0.39	0.47	0.50	ns, Max
T <sub>AXC</sub>	AX inputs to CMUX output	0.39	0.44	0.52	0.56	ns, Max
T <sub>AXD</sub>	AX inputs to DMUX output	0.42	0.47	0.55	0.60	ns, Max
T <sub>BXB</sub>	BX inputs to BMUX output	0.30	0.34	0.39	0.44	ns, Max
T <sub>BXD</sub>	BX inputs to DMUX output	0.38	0.43	0.50	0.55	ns, Max
T <sub>CXC</sub>	CX inputs to CMUX output	0.26	0.29	0.34	0.37	ns, Max
T <sub>CXD</sub>	CX inputs to DMUX output	0.30	0.34	0.40	0.44	ns, Max
T <sub>DXD</sub>	DX inputs to DMUX output	0.30	0.33	0.38	0.43	ns, Max
T <sub>OPCYA</sub>	An input to COUT output	0.32	0.36	0.41	0.47	ns, Max
T <sub>OPCYB</sub>	Bn input to COUT output	0.32	0.36	0.41	0.47	ns, Max
T <sub>OPCYC</sub>	Cn input to COUT output	0.27	0.30	0.34	0.40	ns, Max
T <sub>OPCYD</sub>	Dn input to COUT output	0.25	0.28	0.32	0.37	ns, Max
T <sub>AXCY</sub>	AX input to COUT output	0.25	0.28	0.33	0.36	ns, Max
T <sub>BXCY</sub>	BX input to COUT output	0.22	0.24	0.28	0.31	ns, Max
T <sub>CXCY</sub>	CX input to COUT output	0.15	0.17	0.20	0.22	ns, Max
T <sub>DXCY</sub>	DX input to COUT output	0.14	0.16	0.19	0.21	ns, Max
T <sub>BYP</sub>	CIN input to COUT output	0.06	0.07	0.08	0.09	ns, Max
T <sub>CINA</sub>	CIN input to AMUX output	0.21	0.24	0.28	0.30	ns, Max
T <sub>CINB</sub>	CIN input to BMUX output	0.23	0.25	0.29	0.31	ns, Max
T <sub>CINC</sub>	CIN input to CMUX output	0.23	0.26	0.30	0.33	ns, Max
T <sub>CIND</sub>	CIN input to DMUX output	0.25	0.29	0.33	0.36	ns, Max
<b>Sequential Delays</b>						
T <sub>CKO</sub>	Clock to AQ – DQ outputs	0.29	0.33	0.39	0.44	ns, Max
T <sub>SHCKO</sub>	Clock to AMUX – DMUX outputs	0.36	0.40	0.47	0.53	ns, Max
<b>Setup and Hold Times of CLB Flip-Flops Before/After Clock CLK</b>						
T <sub>DICK</sub> /T <sub>CKDI</sub>	A – D input to CLK on A – D Flip Flops	0.30/0.17	0.36/0.18	0.43/0.20	0.44/0.25	ns, Min
T <sub>CECK_CLB</sub> / T <sub>CKCE_CLB</sub>	CE input to CLK on A – D Flip Flops	0.20/0.00	0.25/0.00	0.32/0.00	0.32/0.01	ns, Min
T <sub>SRCK</sub> /T <sub>CKSR</sub>	SR input to CLK on A – D Flip Flops	0.39/–0.07	0.44/–0.07	0.52/–0.07	0.58/–0.08	ns, Min
T <sub>CINCK</sub> /T <sub>CKCIN</sub>	CIN input to CLK on A – D Flip Flops	0.16/0.12	0.19/0.14	0.24/0.16	0.23/0.22	ns, Min
<b>Set/Reset</b>						
T <sub>SRMIN</sub>	SR input minimum pulse width	0.90	0.90	0.97	0.80	ns, Min
T <sub>RQ</sub>	Delay from SR input to AQ – DQ flip-flops	0.52	0.58	0.68	0.77	ns, Max
T <sub>CEO</sub>	Delay from CE input to AQ – DQ flip-flops	0.41	0.48	0.59	0.61	ns, Max
F <sub>TOG</sub>	Toggle frequency (for export control)	1412.00	1286.40	1098.00	1098.00	MHz

**Notes:**

1. A Zero "0" Hold Time listing indicates no hold time or a negative hold time. Negative values can not be guaranteed "best-case", but if a "0" is listed, there is no positive hold time.
2. These items are of interest for Carry Chain applications.

## DSP48E1 Switching Characteristics

Table 58: DSP48E1 Switching Characteristics

Symbol	Description	Speed Grade					Units
		-3	-2	-1 (XC)	-1 (XQ)	-1L	
<b>Setup and Hold Times of Data/Control Pins to the Input Register Clock</b>							
$T_{D\text{SPDCK}}\{A, ACIN; B, BCIN\}_{A\text{REG}; B\text{REG}}/$ $T_{D\text{SPCKD}}\{A, ACIN; B, BCIN\}_{A\text{REG}; B\text{REG}}$	{A, ACIN, B, BCIN} input to {A, B} register CLK	0.25/ 0.27	0.29/ 0.30	0.35/ 0.34	0.36/ 0.34	0.46/ 0.39	ns
$T_{D\text{SPDCK}}\text{C\_CREG}/T_{D\text{SPCKD}}\text{C\_CREG}$	C input to C register CLK	0.16/ 0.20	0.19/ 0.22	0.22/ 0.24	0.25/ 0.24	0.33/ 0.30	ns
$T_{D\text{SPDCK}}\text{D\_DREG}/T_{D\text{SPCKD}}\text{D\_DREG}$	D input to D register CLK	0.07/ 0.31	0.10/ 0.34	0.15/ 0.39	0.16/ 0.39	0.24/ 0.45	ns
<b>Setup and Hold Times of Data Pins to the Pipeline Register Clock</b>							
$T_{D\text{SPDCK}}\{A, ACIN, B, BCIN\}\text{MREG\_MULT}/$ $T_{D\text{SPCKD}}\{A, ACIN, B, BCIN\}\text{MREG\_MULT}$	{A, ACIN, B, BCIN} input to M register CLK	2.36/ 0.04	2.70/ 0.04	3.21/ 0.04	3.21/ 0.04	3.66/ 0.02	ns
$T_{D\text{SPDCK}}\{A, D\}\text{ADREG}/$ $T_{D\text{SPCKD}}\{A, D\}\text{ADREG}$	{A, D} input to AD register CLK	1.24/ 0.10	1.42/ 0.12	1.69/ 0.13	1.69/ 0.13	1.91/ 0.16	ns
<b>Setup and Hold Times of Data/Control Pins to the Output Register Clock</b>							
$T_{D\text{SPDCK}}\{A, ACIN, B, BCIN\}\text{PREG\_MULT}/$ $T_{D\text{SPCKD}}\{A, ACIN, B, BCIN\}\text{PREG\_MULT}$	{A, ACIN, B, BCIN} input to P register CLK using multiplier	3.83/ -0.13	4.37/ -0.13	5.20/ -0.13	5.20/ -0.13	5.94/ -0.24	ns
$T_{D\text{SPDCK}}\text{D\_PREG\_MULT}/T_{D\text{SPCKD}}\text{D\_PREG\_MULT}$	D input to P register CLK	3.62/ -0.47	4.13/ -0.47	4.90/ -0.47	4.90/ -0.47	5.61/ -0.77	ns
$T_{D\text{SPDCK}}\{A, ACIN, B, BCIN\}\text{PREG}/$ $T_{D\text{SPCKD}}\{A, ACIN, B, BCIN\}\text{PREG}$	{A, ACIN, B, BCIN} input to P register CLK not using multiplier	1.59/ -0.13	1.81/ -0.13	2.15/ -0.13	2.15/ -0.13	2.44/ -0.24	ns
$T_{D\text{SPDCK}}\text{C\_PREG}/T_{D\text{SPCKD}}\text{C\_PREG}$	C input to P register CLK	1.42/ -0.10	1.61/ -0.10	1.91/ -0.10	1.91/ -0.10	2.16/ -0.19	ns
$T_{D\text{SPDCK}}\{\text{PCIN, CARRYCASCIN, MULTSIGNIN}\}\text{PREG}/$ $T_{D\text{SPCKD}}\{\text{PCIN, CARRYCASCIN, MULTSIGNIN}\}\text{PREG}$	{PCIN, CARRYCASCIN, MULTSIGNIN} input to P register CLK	1.23/ -0.02	1.41/ -0.02	1.67/ -0.02	1.67/ -0.02	1.91/ -0.07	ns
<b>Setup and Hold Times of the CE Pins</b>							
$T_{D\text{SPDCK}}\{\text{CEA; CEB}\}_{A\text{REG}; B\text{REG}}/$ $T_{D\text{SPCKD}}\{\text{CEA; CEB}\}_{A\text{REG}; B\text{REG}}$	{CEA; CEB} input to {A; B} register CLK	0.14/ 0.19	0.17/ 0.22	0.22/ 0.25	0.22/ 0.25	0.30/ 0.28	ns
$T_{D\text{SPDCK}}\text{CEC\_CREG}/T_{D\text{SPCKD}}\text{CEC\_CREG}$	CEC input to C register CLK	0.15/ 0.18	0.18/ 0.20	0.24/ 0.23	0.24/ 0.23	0.31/ 0.26	ns
$T_{D\text{SPDCK}}\text{CED\_DREG}/T_{D\text{SPCKD}}\text{CED\_DREG}$	CED input to D register CLK	0.20/ 0.12	0.24/ 0.13	0.31/ 0.14	0.31/ 0.14	0.43/ 0.16	ns
$T_{D\text{SPDCK}}\text{CEM\_MREG}/T_{D\text{SPCKD}}\text{CEM\_MREG}$	CEM input to M register CLK	0.16/ 0.19	0.20/ 0.21	0.26/ 0.25	0.26/ 0.25	0.32/ 0.28	ns
$T_{D\text{SPDCK}}\text{CEP\_PREG}/T_{D\text{SPCKD}}\text{CEP\_PREG}$	CEP input to P register CLK	0.32/ 0.02	0.38/ 0.02	0.46/ 0.03	0.46/ 0.03	0.54/ 0.04	ns
<b>Setup and Hold Times of the RST Pins</b>							
$T_{D\text{SPDCK}}\{\text{RSTA; RSTB}\}_{A\text{REG}; B\text{REG}}/$ $T_{D\text{SPCKD}}\{\text{RSTA; RSTB}\}_{A\text{REG}; B\text{REG}}$	{RSTA, RSTB} input to {A, B} register CLK	0.27/ 0.17	0.31/ 0.19	0.38/ 0.22	0.38/ 0.22	0.41/ 0.25	ns
$T_{D\text{SPDCK}}\text{RSTC\_CREG}/T_{D\text{SPCKD}}\text{RSTC\_CREG}$	RSTC input to C register CLK	0.18/ 0.08	0.20/ 0.08	0.23/ 0.09	0.23/ 0.09	0.27/ 0.11	ns
$T_{D\text{SPDCK}}\text{RSTD\_DREG}/T_{D\text{SPCKD}}\text{RSTD\_DREG}$	RSTD input to D register CLK	0.28/ 0.15	0.32/ 0.16	0.38/ 0.19	0.38/ 0.19	0.45/ 0.21	ns
$T_{D\text{SPDCK}}\text{RSTM\_MREG}/T_{D\text{SPCKD}}\text{RSTM\_MREG}$	RSTM input to M register CLK	0.20/ 0.24	0.23/ 0.26	0.26/ 0.30	0.26/ 0.30	0.29/ 0.34	ns

Table 59: Configuration Switching Characteristics (Cont'd)

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
$T_{MMCMDCK\_DI}/T_{MMCCKD\_DI}$	DI Setup/Hold	1.25/ 0.00	1.40/ 0.00	1.63/ 0.00	1.64/ 0.00	ns
$T_{MMCMDCK\_DEN}/T_{MMCCKD\_DEN}$	DEN Setup/Hold time	1.25/ 0.00	1.40/ 0.00	1.63/ 0.00	1.64/ 0.00	ns
$T_{MMCMDCK\_DWE}/T_{MMCCKD\_DWE}$	DWE Setup/Hold time	1.25/ 0.00	1.40/ 0.00	1.63/ 0.00	1.64/ 0.00	ns
$T_{MMCCKO\_DO}$	CLK to out of DO <sup>(3)</sup>	2.60	3.02	3.64	3.68	ns
$T_{MMCCKO\_DRDY}$	CLK to out of DRDY	0.32	0.34	0.38	0.38	ns

**Notes:**

1. To support longer delays in configuration, use the design solutions described in [UG360: Virtex-6 FPGA Configuration User Guide](#).
2. Only during configuration, the last edge is determined by a weak pull-up/pull-down resistor in the I/O.
3. DO will hold until next DRP operation.

**Clock Buffers and Networks**

Table 60: Global Clock Switching Characteristics (Including BUFCTRL)

Symbol	Description	Devices	Speed Grade				Units
			-3	-2	-1	-1L	
$T_{BCCCK\_CE}/T_{BCCCK\_CE}^{(1)}$	CE pins Setup/Hold	All	0.11/ 0.00	0.13/ 0.00	0.16/ 0.00	0.13/ 0.00	ns
$T_{BCCCK\_S}/T_{BCCCK\_S}^{(1)}$	S pins Setup/Hold	All	0.11/ 0.00	0.13/ 0.00	0.16/ 0.00	0.13/ 0.00	ns
$T_{BCCCKO\_O}^{(2)}$	BUFCTRL delay from I0/I1 to O	All	0.07	0.08	0.10	0.10	ns
<b>Maximum Frequency</b>							
$F_{MAX}$	Global clock tree (BUFCTRL)	All except LX760	800	750	700	667	MHz
		LX760	N/A	700	700	667	MHz

**Notes:**

1.  $T_{BCCCK\_CE}$  and  $T_{BCCCK\_S}$  must be satisfied to assure glitch-free operation of the global clock when switching between clocks. These parameters do not apply to the BUFCTRL\_VIRTEX4 primitive that assures glitch-free operation. The other global clock setup and hold times are optional; only needing to be satisfied if device operation requires simulation matches on a cycle-for-cycle basis when switching between clocks.
2.  $T_{BCCCKO\_O}$  (BUFCTRL delay from I0 to O) values are the same as  $T_{BCCCKO\_O}$  values.

Table 61: Input/Output Clock Switching Characteristics (BUFIO)

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
$T_{BIOCKO\_O}$	Clock to out delay from I to O	0.14	0.16	0.18	0.21	ns
<b>Maximum Frequency</b>						
$F_{MAX}$	I/O clock tree (BUFIO)	800	800	710	710	MHz

Table 62: Regional Clock Switching Characteristics (BUFR)

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
$T_{BRCKO\_O}$	Clock to out delay from I to O	0.56	0.62	0.73	0.82	ns
$T_{BRCKO\_O\_BYP}$	Clock to out delay from I to O with Divide Bypass attribute set	0.28	0.31	0.36	0.41	ns

**Table 64: MMCM Specification (Cont'd)**

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
$RST_{MINPULSE}$	Minimum Reset Pulse Width	1.5	1.5	1.5	1.5	ns
$F_{PFDMAX}$	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to High or Optimized <sup>(9)</sup>	550	500	450	450	MHz
	Maximum Frequency at the Phase Frequency Detector with Bandwidth Set to Low	300	300	300	300	MHz
$F_{PFDMIN}$	Minimum Frequency at the Phase Frequency Detector with Bandwidth Set to High or Optimized	135	135	135	135	MHz
	Minimum Frequency at the Phase Frequency Detector with Bandwidth Set to Low	10	10	10	10	MHz
$T_{FBDELAY}$	Maximum Delay in the Feedback Path	3 ns Max or one CLKIN cycle				
$T_{MMCMCKD\_PSEN}/$ $T_{MMCMCKD\_PSEN}$	Setup and Hold of Phase Shift Enable	1.04 0.00	1.04 0.00	1.04 0.00	1.04 0.00	ns
$T_{MMCMCKD\_PSINCDEC}/$ $T_{MMCMCKD\_PSINCDEC}$	Setup and Hold of Phase Shift Increment/Decrement	1.04 0.00	1.04 0.00	1.04 0.00	1.04 0.00	ns
$T_{MMCMCKO\_PSDONE}$	Phase Shift Clock-to-Out of PSDONE	0.32	0.34	0.38	0.38	ns

**Notes:**

- When  $DIVCLK\_DIVIDE = 3$  or  $4$ ,  $F_{INMAX}$  is 315 MHz.
- This duty cycle specification does not apply to the GTH\_QUAD (GTH) to MMCM connection. The GTH transceivers drive the MMCMs at the following maximum frequencies: 323 MHz for -1 speed grade devices, 350 MHz for -2 speed grade devices, or 350 MHz for -3 speed grade devices.
- The MMCM does not filter typical spread-spectrum input clocks because they are usually far below the bandwidth filter frequencies.
- The static offset is measured between any MMCM outputs with identical phase.
- Values for this parameter are available in the Clocking Wizard.  
See [http://www.xilinx.com/products/intellectual-property/clocking\\_wizard.htm](http://www.xilinx.com/products/intellectual-property/clocking_wizard.htm).
- Includes global clock buffer.
- Calculated as  $F_{VCO}/128$  assuming output duty cycle is 50%.
- When  $CASCADE4\_OUT = TRUE$ ,  $F_{OUTMIN}$  is 0.036 MHz.
- In ISE software 12.3 (or earlier versions supporting the Virtex-6 family), the phase frequency detector Optimized bandwidth setting is equivalent to the High bandwidth setting. Starting with ISE software 12.4, the Optimized bandwidth setting is automatically adjusted to Low when the software can determine that the phase frequency detector input is less than 135 MHz.

## Virtex-6 Device Pin-to-Pin Output Parameter Guidelines

All devices are 100% functionally tested. The representative values for typical pin locations and normal clock loading are listed in [Table 65](#). Values are expressed in nanoseconds unless otherwise noted.

*Table 65: Global Clock Input to Output Delay Without MMCM*

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
LVCMOS25 Global Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>without</i> MMCM.							
T <sub>ICKOF</sub>	Global Clock input and OUTFF <i>without</i> MMCM	XC6VLX75T	4.91	5.32	5.88	6.02	ns
		XC6VLX130T	4.89	5.33	6.00	6.13	ns
		XC6VLX195T	5.02	5.46	6.13	6.27	ns
		XC6VLX240T	5.02	5.46	6.13	6.27	ns
		XC6VLX365T	5.30	5.75	6.43	6.37	ns
		XC6VLX550T	N/A	6.02	6.72	6.60	ns
		XC6VLX760	N/A	6.26	6.97	6.87	ns
		XC6VSX315T	5.40	5.85	6.54	6.49	ns
		XC6VSX475T	N/A	6.01	6.71	6.61	ns
		XC6VHX250T	5.18	5.63	6.30	N/A	ns
		XC6VHX255T	5.20	5.66	6.34	N/A	ns
		XC6VHX380T	5.38	5.84	6.53	N/A	ns
		XC6VHX565T	N/A	6.03	6.71	N/A	ns
		XQ6VLX130T	N/A	5.33	6.00	6.13	ns
		XQ6VLX240T	N/A	5.46	6.13	6.27	ns
		XQ6VLX550T	N/A	N/A	6.72	6.60	ns
		XQ6VSX315T	N/A	5.85	6.54	6.49	ns
XQ6VSX475T	N/A	N/A	6.71	6.61	ns		

**Notes:**

- Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.

**Table 67: Clock-Capable Clock Input to Output Delay With MMCM**

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
LVCMOS25 Clock-capable Clock Input to Output Delay using Output Flip-Flop, 12mA, Fast Slew Rate, <i>with</i> MMCM.							
T <sub>ICKOFMMCMCC</sub>	Clock-capable Clock Input and OUTFF <i>with</i> MMCM	XC6VLX75T	2.22	2.38	2.63	2.72	ns
		XC6VLX130T	2.24	2.39	2.65	2.74	ns
		XC6VLX195T	2.24	2.40	2.65	2.75	ns
		XC6VLX240T	2.24	2.40	2.65	2.75	ns
		XC6VLX365T	2.25	2.42	2.65	2.76	ns
		XC6VLX550T	N/A	2.43	2.68	2.80	ns
		XC6VLX760	N/A	2.42	2.69	2.79	ns
		XC6VSX315T	2.23	2.38	2.65	2.73	ns
		XC6VSX475T	N/A	2.30	2.57	2.66	ns
		XC6VHX250T	2.25	2.41	2.67	N/A	ns
		XC6VHX255T	2.35	2.51	2.78	N/A	ns
		XC6VHX380T	2.27	2.43	2.69	N/A	ns
		XC6VHX565T	N/A	2.41	2.68	N/A	ns
		XQ6VLX130T	N/A	2.39	2.65	2.74	ns
		XQ6VLX240T	N/A	2.40	2.65	2.75	ns
		XQ6VLX550T	N/A	N/A	2.68	2.80	ns
		XQ6VSX315T	N/A	2.38	2.65	2.73	ns
		XQ6VSX475T	N/A	N/A	2.57	2.66	ns

**Notes:**

1. Listed above are representative values where one global clock input drives one vertical clock line in each accessible column, and where all accessible IOB and CLB flip-flops are clocked by the global clock net.
2. MMCM output jitter is already included in the timing calculation.

Table 69: Global Clock Input Setup and Hold With MMCM

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
<b>Input Setup and Hold Time Relative to Global Clock Input Signal for LVCMOS25 Standard.<sup>(1)</sup></b>							
T <sub>PSMMCMGC</sub> / T <sub>PHMMCMGC</sub>	No Delay Global Clock Input and IFF <sup>(2)</sup> with MMCM	XC6VLX75T	1.45/ -0.18	1.57/ -0.18	1.72/ -0.18	1.78/ -0.08	ns
		XC6VLX130T	1.53/ -0.18	1.65/ -0.18	1.81/ -0.18	1.87/ -0.07	ns
		XC6VLX195T	1.54/ -0.17	1.66/ -0.17	1.82/ -0.17	1.87/ -0.08	ns
		XC6VLX240T	1.54/ -0.17	1.66/ -0.17	1.82/ -0.17	1.87/ -0.08	ns
		XC6VLX365T	1.55/ -0.18	1.67/ -0.18	1.83/ -0.18	1.87/ -0.07	ns
		XC6VLX550T	N/A	1.84/ -0.17	2.02/ -0.17	2.06/ -0.06	ns
		XC6VLX760	N/A	2.26/ -0.13	2.49/ -0.13	2.06/ -0.03	ns
		XC6VSX315T	1.56/ -0.18	1.68/ -0.18	1.84/ -0.18	1.89/ -0.08	ns
		XC6VSX475T	N/A	1.85/ -0.23	2.03/ -0.23	2.07/ -0.13	ns
		XC6VHX250T	1.52/ -0.17	1.64/ -0.17	1.80/ -0.17	N/A	ns
		XC6VHX255T	1.52/ -0.12	1.64/ -0.12	1.85/ -0.12	N/A	ns
		XC6VHX380T	1.68/ -0.16	1.81/ -0.16	1.99/ -0.16	N/A	ns
		XC6VHX565T	N/A	1.81/ -0.01	1.99/ -0.01	N/A	ns
		XQ6VLX130T	N/A	1.65/ -0.18	1.81/ -0.18	1.87/ -0.07	ns
		XQ6VLX240T	N/A	1.66/ -0.17	1.82/ -0.17	1.87/ -0.08	ns
		XQ6VLX550T	N/A	N/A	2.02/ -0.17	2.06/ -0.06	ns
		XQ6VSX315T	N/A	1.68/ -0.18	1.84/ -0.18	1.89/ -0.08	ns
		XQ6VSX475T	N/A	N/A	2.03/ -0.23	2.07/ -0.13	ns

**Notes:**

1. Setup and Hold times are measured over worst case conditions (process, voltage, temperature). Setup time is measured relative to the Global Clock input signal using the slowest process, highest temperature, and lowest voltage. Hold time is measured relative to the Global Clock input signal using the fastest process, lowest temperature, and highest voltage.
2. IFF = Input Flip-Flop or Latch
3. Use IBIS to determine any duty-cycle distortion incurred using various standards.

Table 73: Sample Window

Symbol	Description	Device	Speed Grade				Units
			-3	-2	-1	-1L	
T <sub>SAMP</sub>	Sampling Error at Receiver Pins <sup>(1)</sup>	All	510	560	610	670	ps
T <sub>SAMP_BUFIO</sub>	Sampling Error at Receiver Pins using BUFIO <sup>(2)</sup>	All	300	350	400	440	ps

**Notes:**

1. This parameter indicates the total sampling error of Virtex-6 FPGA DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the MMCM to capture the DDR input registers' edges of operation. These measurements include:
  - CLK0 MMCM jitter
  - MMCM accuracy (phase offset)
  - MMCM phase shift resolution
 These measurements do not include package or clock tree skew.
2. This parameter indicates the total sampling error of Virtex-6 FPGA DDR input registers, measured across voltage, temperature, and process. The characterization methodology uses the BUFIO clock network and IODELAY to capture the DDR input registers' edges of operation. These measurements do not include package or clock tree skew.

Table 74: Pin-to-Pin Setup/Hold and Clock-to-Out

Symbol	Description	Speed Grade				Units
		-3	-2	-1	-1L	
<b>Data Input Setup and Hold Times Relative to a Forwarded Clock Input Pin Using BUFIO</b>						
T <sub>PSCS</sub> /T <sub>PHCS</sub>	Setup/Hold of I/O clock	-0.28/1.09	-0.28/1.16	-0.28/1.33	-0.18/1.79	ns
<b>Pin-to-Pin Clock-to-Out Using BUFIO</b>						
T <sub>ICKOFCS</sub>	Clock-to-Out of I/O clock	4.22	4.59	5.22	5.63	ns

## Revision History

The following table shows the revision history for this document:

Date	Version	Description of Revisions
06/24/09	1.0	Initial Xilinx release.
07/16/09	1.1	Revised the maximum V <sub>CCAUX</sub> and V <sub>IN</sub> numbers in Table 2, page 2. Removed empty column from Table 3, page 3. Revised specifications on Table 20, page 13. Updated Table 38, page 22 and added notes 1 and 2. Revised T <sub>DLYCCO_RDY</sub> , T <sub>IDELAYCTRL_RPW</sub> , and T <sub>IDELAYPAT_JIT</sub> in Table 53, page 41. Updated Table 58, page 46 to more closely match the DSP48E1 speed specifications. Updated T <sub>TAPTCK</sub> /T <sub>TCKTAP</sub> in Table 59, page 49. Updated XC6VLX130T parameters in Table 68 through Table 70, page 59.
08/19/09	1.2	Added values for -1L voltages and speed grade in all pertinent tables. Added V <sub>FS</sub> and notes to Table 1 and Table 2. Removed DV <sub>PPIN</sub> from the example in Figure 2. Added networking applications to Table 41, page 25. Changed and added to the block RAM F <sub>MAX</sub> section in Table 57, page 44 including removing Note 12. Changed F <sub>PFDMAX</sub> values and corrected units for T <sub>STATPHAOFFSET</sub> and T <sub>OUTDUTY</sub> in Table 64, page 52. Updated Table 71, page 60.
09/16/09	2.0	Added Virtex-6 HXT devices to entire document including GTH Transceiver Specifications. Updated speed specifications as described in Switching Characteristics, includes changes in Table 51, Table 57, Table 58, and Table 66 through Table 70. Comprehensive changes to Table 14, Table 15, and Table 16. Added conditions to D <sub>VPPOUT</sub> and revised description of T <sub>OSKEW</sub> in Table 17. Removed V <sub>ISE</sub> specification and note from Table 18. Added note 3 to Table 23. Updated note 3 in Table 24. Updated LVCMOS25 delays in Table 44. Updated specification for T <sub>IOTPHZ</sub> in Table 46. Removed T <sub>BUFHSKEW</sub> from Table 71, page 60 and added values for T <sub>BUFIOSKEW</sub> . Added values in Table 74.